

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination BEDNASZ ET AL.	
		Examiner Yuwen Pan	Art Unit 2618	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,825,331	10-1998	Lee, Ae-Kyoung	343/703
*	B	US-7,286,961	10-2007	Kildal, Per-Simon	702/182
*	C	US-6,329,953	12-2001	McKivergan, Patrick D.	343/703
*	D	US-7,035,594	04-2006	Wallace et al.	455/67.12
*	E	US-6,795,030	09-2004	Klingler et al.	343/703
F	US-				
G	US-				
H	US-				
I	US-				
J	US-				
K	US-				
L	US-				
M	US-				

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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